



# **Beam Diagnostics for Ion Sources**

# CERN Accelerator School 2012 Uli Raich CERN BE/BI

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#### The LHC and its injectors





$$\mathscr{L} = f \frac{n_1 n_2}{4\sqrt{\epsilon_x \,\beta_x^* \,\epsilon_y \,\beta_y^*}}$$

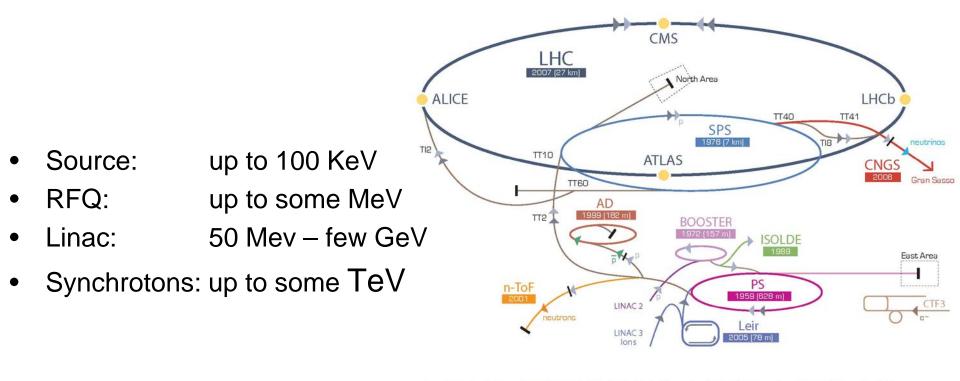
High particle density, small emittance -> high luminosity

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#### **CERN** accelerator chain for Hadrons





 $\rightarrow$  p (proton)  $\rightarrow$  ion  $\rightarrow$  neutrons  $\rightarrow$  p (antiproton)  $\rightarrow$  proton/antiproton conversion  $\rightarrow$  neutrinos  $\rightarrow$  electron

LHC Large Hadron Collider SPS Super Proton Synchrotron PS Proton Synchrotron

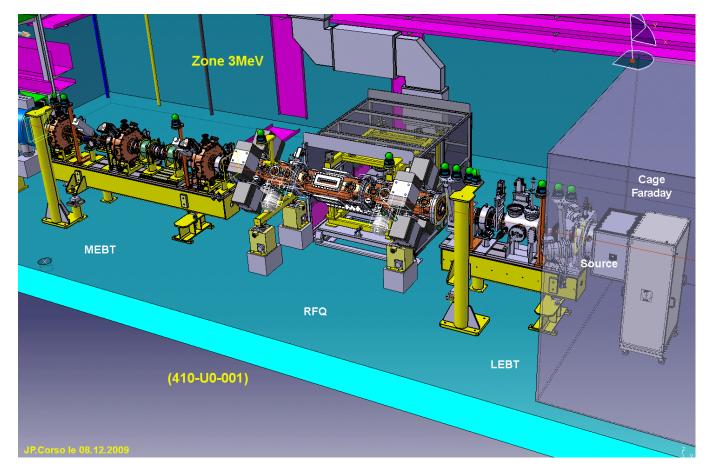
AD Antiproton Decelerator CTF3 Clic Test Facility CNGS Cern Neutrinos to Gran Sasso ISOLDE Isotope Separator OnLine Device LEIR Low Energy Ion Ring LINAC LINear ACcelerator n-ToF Neutrons Time Of Flight

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#### Source and RFQ





Source and LEBT determine beam properties later in the accelerator chain

Need to measure beam parameters before entering the RFQ

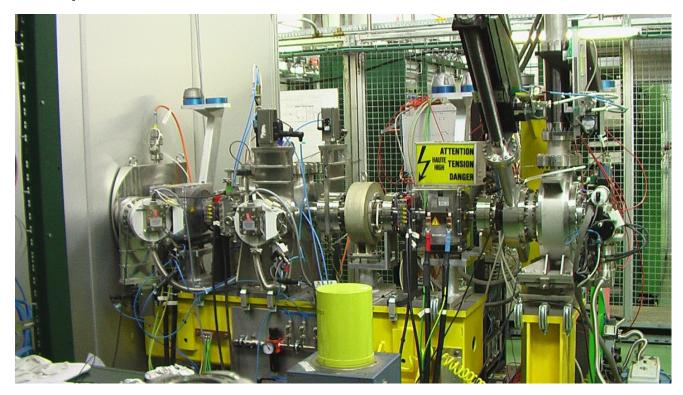
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Transport beam from the source to the RFQ





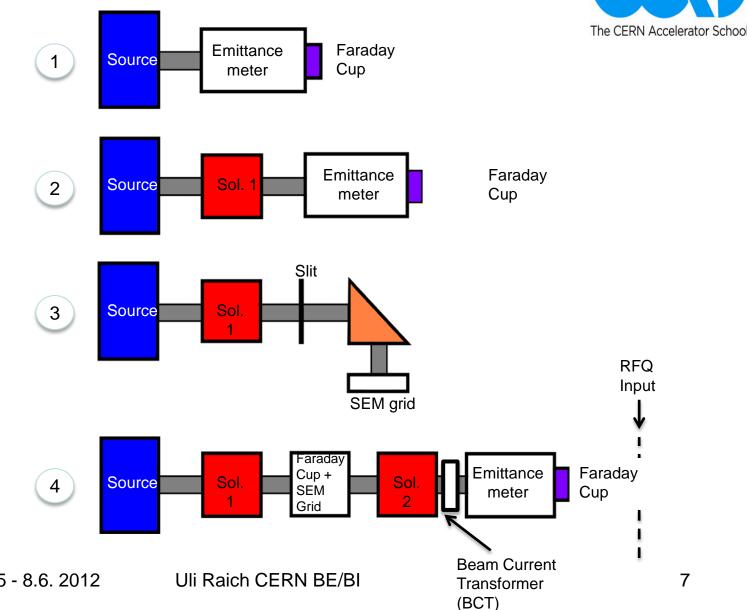
Parameters to be measured



- Beam Intensity
  - Faraday Cup (destructive)
  - Transformer (non destructive)
- Transverse Profile
  - Wire Harps and Wire Scanners
  - Residual Gas Monitors
- Transverse Phase space
  - Slit/Grid device
  - Allison Scanner
  - Pepperpot
- Energy and Energy Spread
  - Spectrometer



### **LEBT Commissioning Stages**



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Parameters to be measured

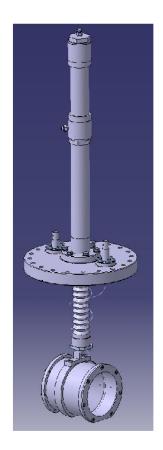


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# Faraday Cup



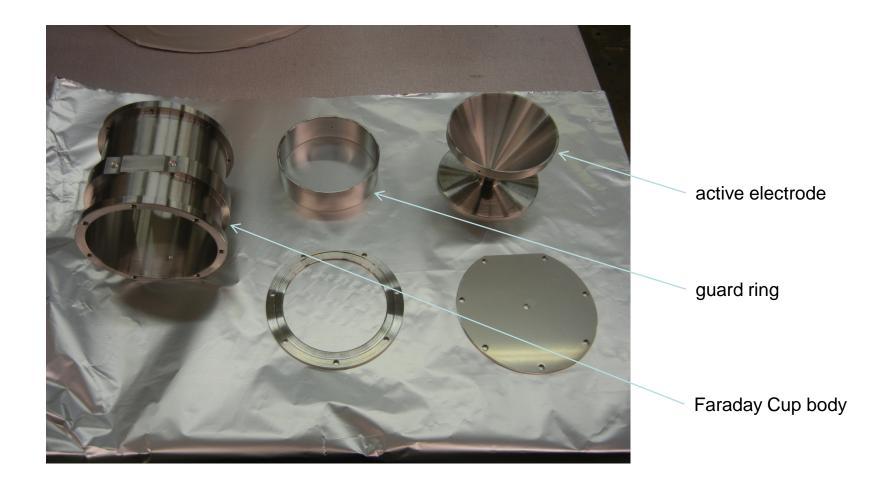


- Source intensity measured by a retractable Faraday
  Cup
- Secondary electron emission is suppressed by polarization voltage which also eliminates parasitic electrons created in the source
- Pneumatic in/out mechanism on PLC is used to enter and retract the cup into/from the beam
- Oscilloscope is used for signal observation
- A ~ 1 MHz sampling ADC may be used to acquire the Faraday Cup signal



#### Faraday Cup pieces





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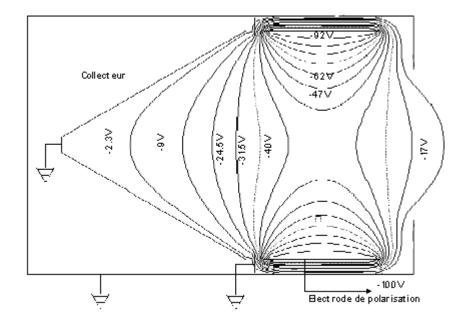


#### Electro-static Field in Faraday Cup



In order to keep secondary electrons within the cup a repelling voltage is applied to the polarization electrode

Since the electrons have energies of less than 20 eV some 100V repelling voltage is sufficient

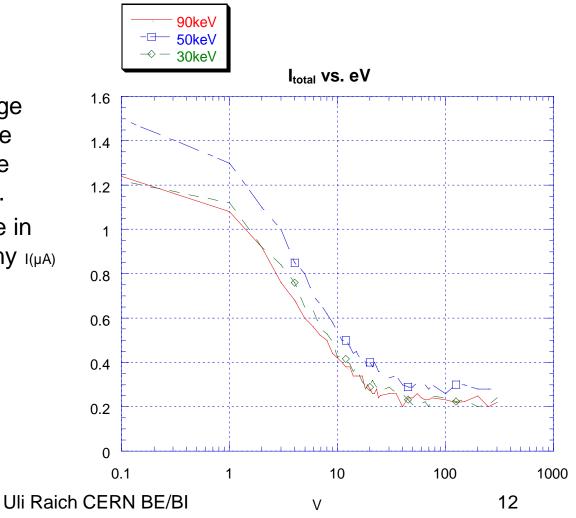




#### Energy of secondary emission electrons



- With increasing repelling voltage the electrons do not escape the Faraday Cup any more and the current measured stays stable.
- At 40V and above no decrease in the Cup current is observed any I(µA) more

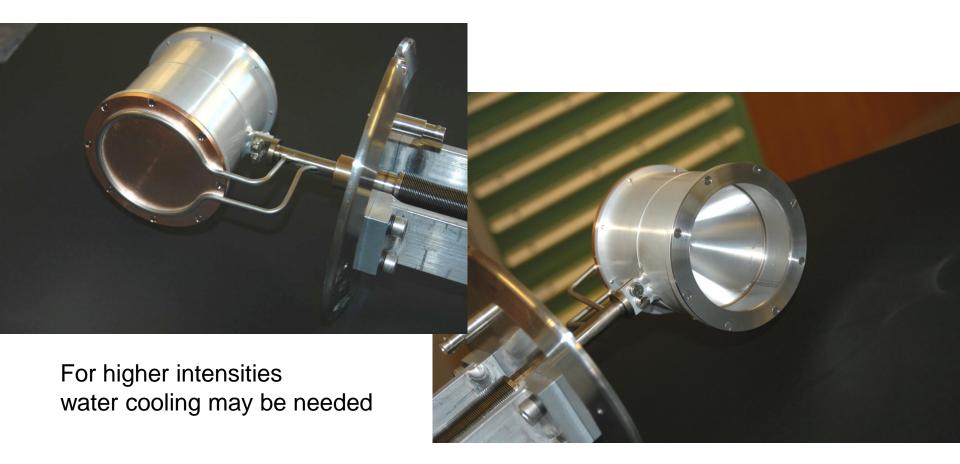


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### Faraday Cup with water cooling





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# **Current Transformers**



Magnetic field

Fields are very low

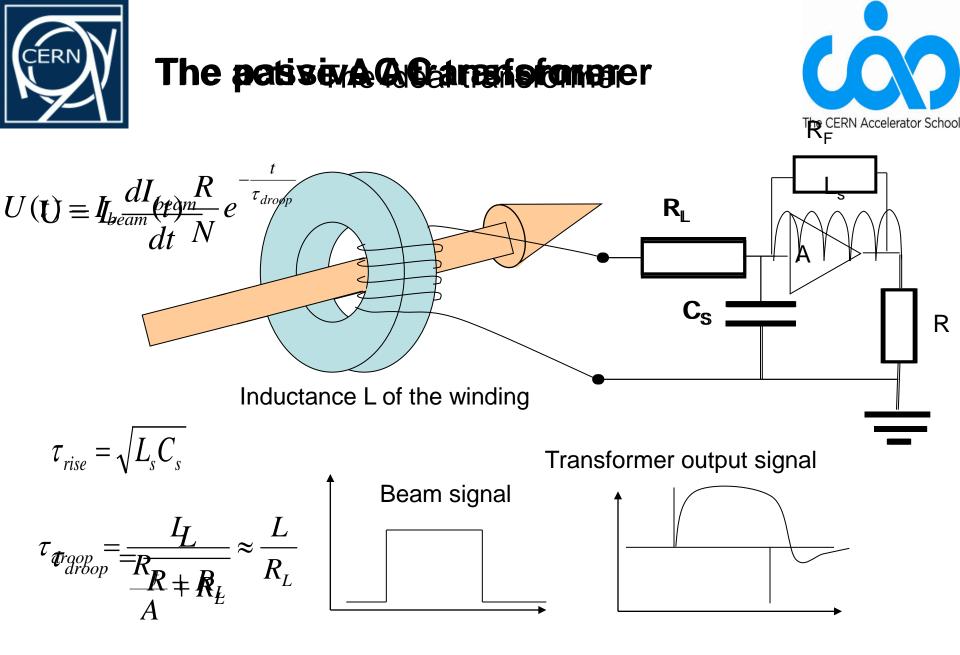
Capture magnetic field lines with cores of high relative permeability

(CoFe based amorphous alloy Vitrovac:  $\mu_r = 10^5$ )

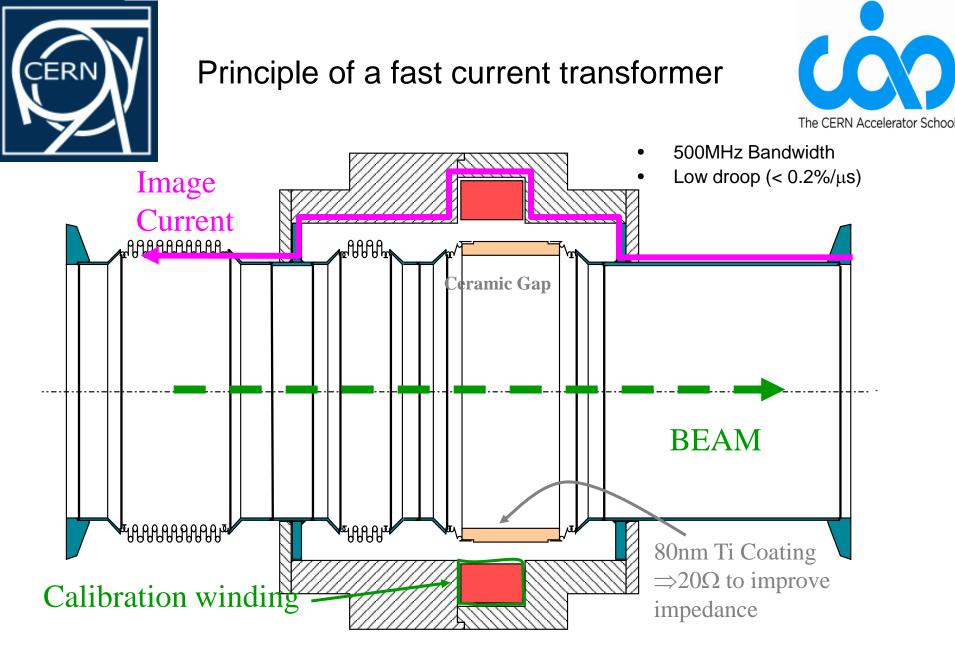
Beam current

$$I_{\text{beam}} = \frac{\text{qeN}}{\text{t}} = \frac{\text{qeN}\beta c}{1} \qquad L = \frac{\mu_0 \mu_r}{2\pi} lN^2 \ln \frac{r_0}{r_i}$$

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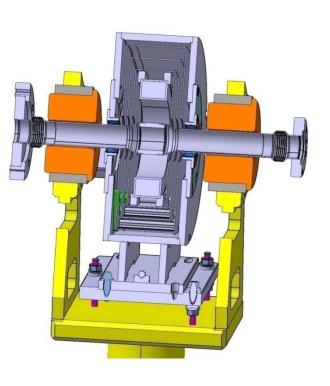


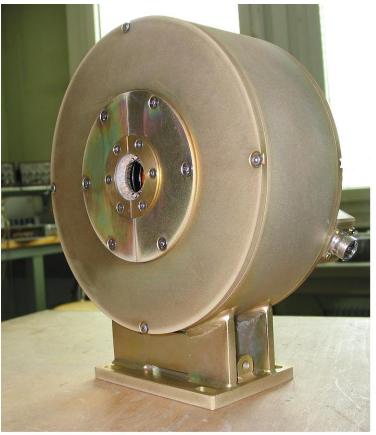
## **Current Transformers**



Good magnetic shielding avoids interference from nearby pulsing magnets

Shielding simulation and test measurements have been done

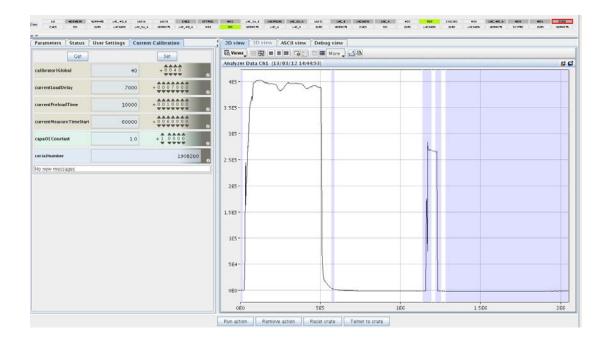






#### **Typical Transformer Signal**





Calibration signal before after beam pulse

Digitization of 400  $\mu s$  pulse at 10 MHz

#### Measures

- total intensity
- intensity per Booster ring

Background suppression by software

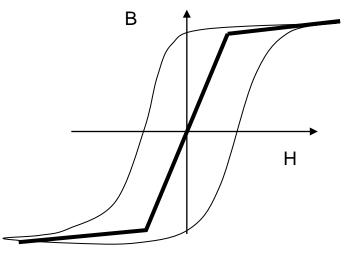
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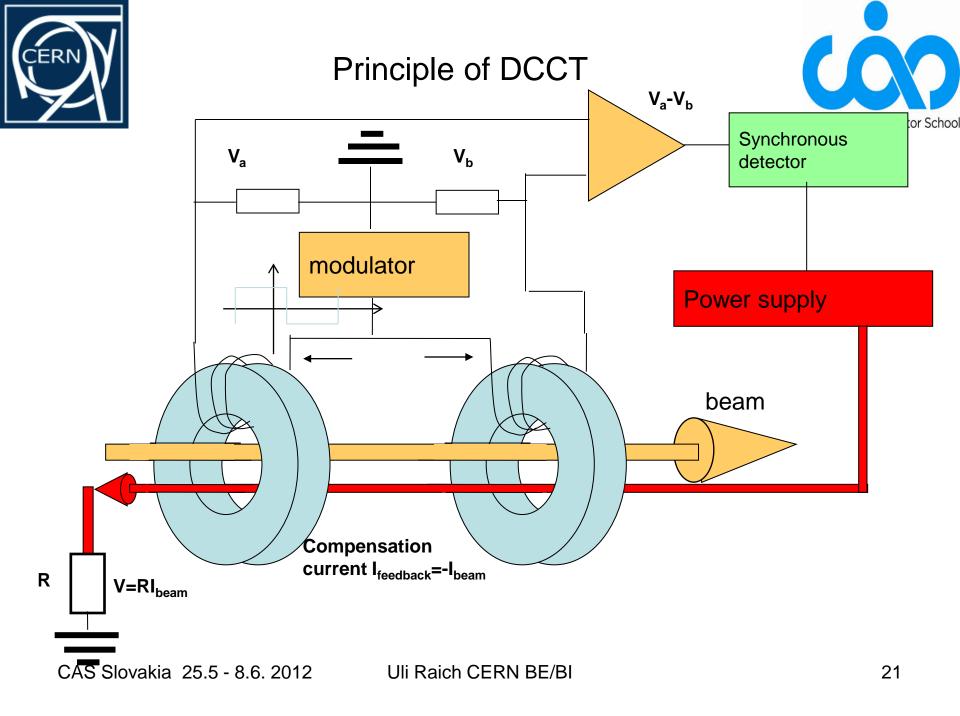
The DC current transformer



- AC current transformer can be extended to very long droop times but not to DC
- Measuring DC currents is needed on DC ion sources
- Must provide a modulation frequency
- Takes advantage of non/linear magnetisation curve



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#### Modulation of a DCCT without beam

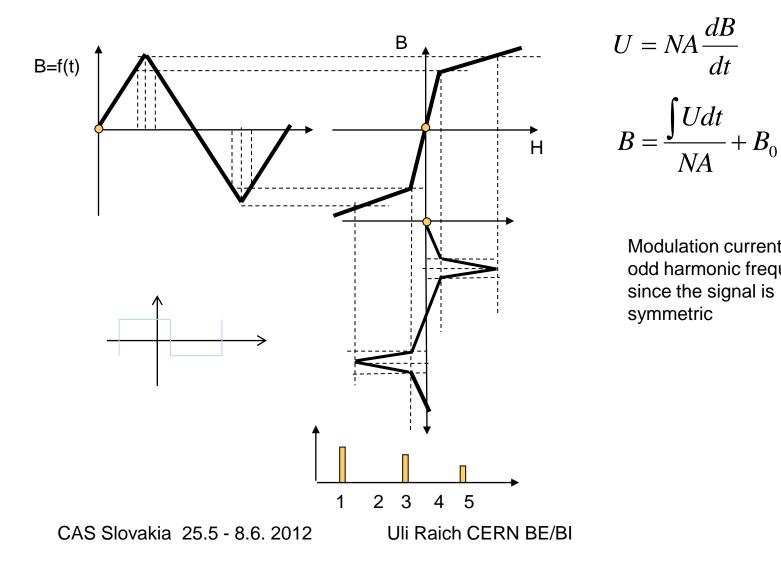


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Modulation current has only odd harmonic frequencies

since the signal is

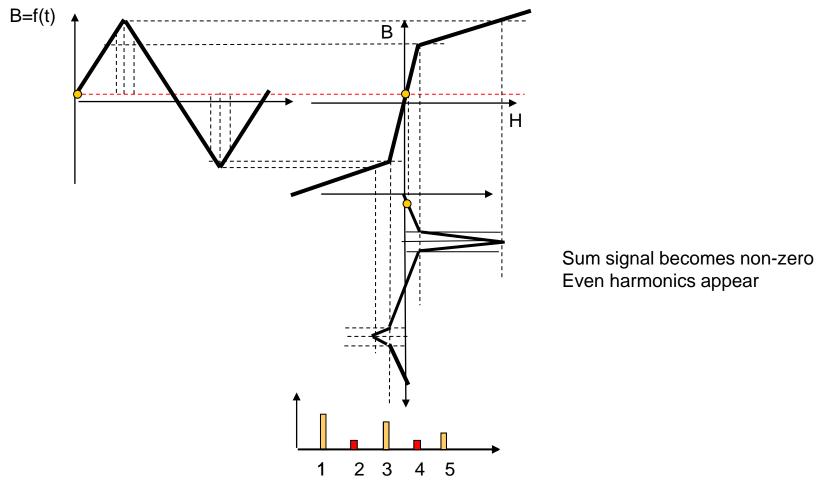
symmetric





#### Modulation of a DCCT with beam



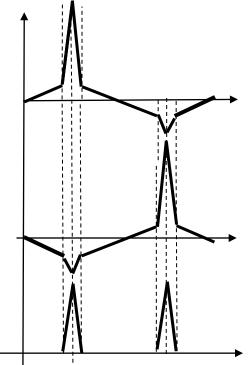


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- Difference signal has  $2\omega_m$
- $\omega_m$  typically 200 Hz 10 kHz
- Use low pass filter with  $\omega_c << \omega_m$
- Provide a 3rd core, normal AC transformer to extend to higher frequencies





### Photo of DCCT internals





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# SEMGrids for Profile Meas.





- SEMGrid resolution: up to 0.5mm, up to 36 wires
- New analogue electronics for 36 under design
- Needs time resolved measurements (200 kHz)
- New VME readout card has been developed (36 channels), series of 50 cards have been produced
- In/out mechanism by motor with PLC control

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#### Wire Scanners



Slowly drives the wire through the beam Measures wire position and collected current on the wire Reconstructs the beam profile



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## **Ionisation Profile Monitor**



- An lonization Profile Monitor (IPM) measures beam profile by collecting rest gas molecules/electrons ionized by the beam.
- The ions/electrons are guided by electric field to MCP
- Gas injection may be needed to increase yield
- Micro-channel plates age, and need to be replaced.



#### Luminescence Monitor



- Gas fluorescence monitor measures light emitted by atoms/molecules excited by the beam.
- Cross sections much lower than for ionization
- Light emittance isotropically.
- What is the rest gas pressure?

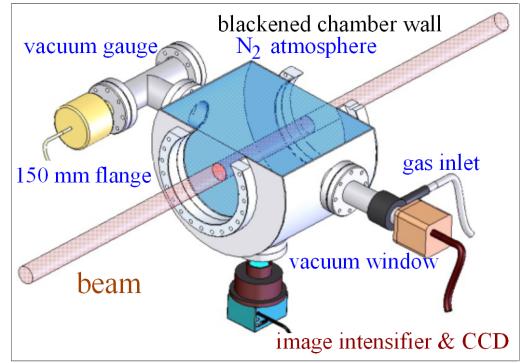


Figure 1: Scheme of a BIF-Monitor.

F. Becker et al, GSI



#### Parameters to be measured



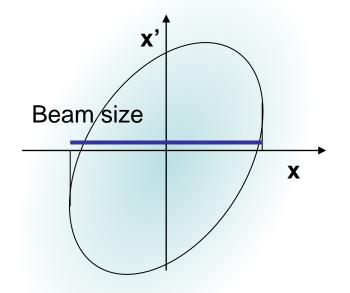
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#### Emittance measurements



- If for each beam particle we plot its position and its transverse angle we get a particle distribution who's boundary is an usually ellipse.
- The projection onto the x axis is the beam size

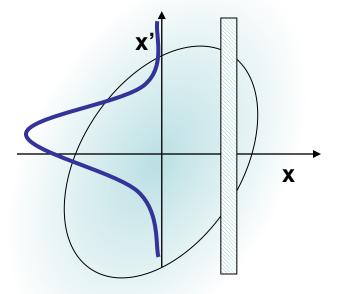




#### The slit and grid method



- If we place a slit into the beam we cut out a small vertical slice of phase space
- Converting the angles into position through a drift space allows to reconstruct the angular distribution at the position defined by the slit



slit

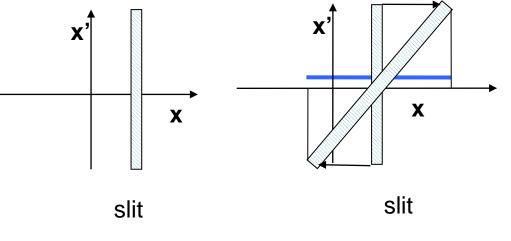


# Transforming angular distribution to profile

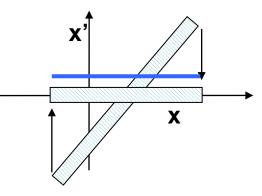


Influence of a drift space

- When moving through a drift space the angles don't change (horizontal move in phase space)
- When moving through a quadrupole the position does not change but the angle does (vertical move in phase space)



Influence of a quadrupole



slit

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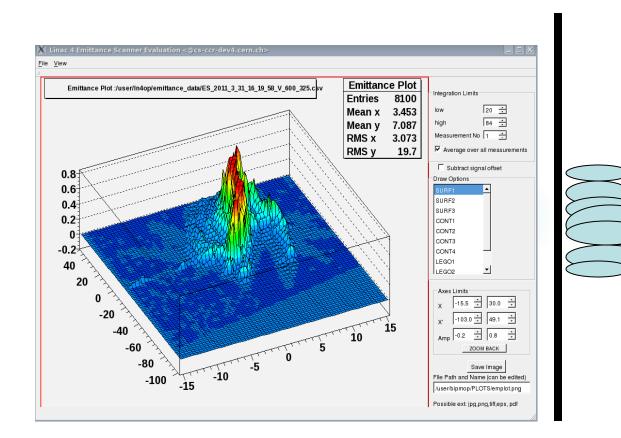
Uli Raich CERN BE/BI

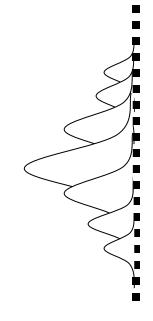
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#### The Slit Method





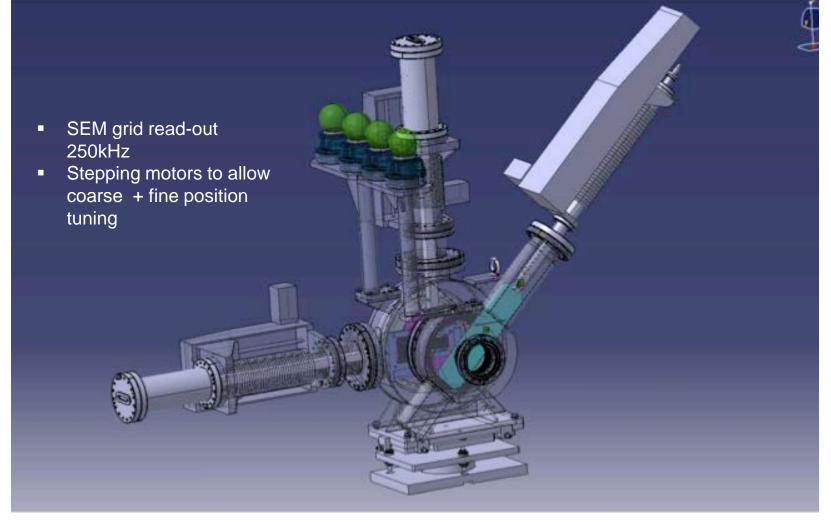


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### **Emittance Meter**

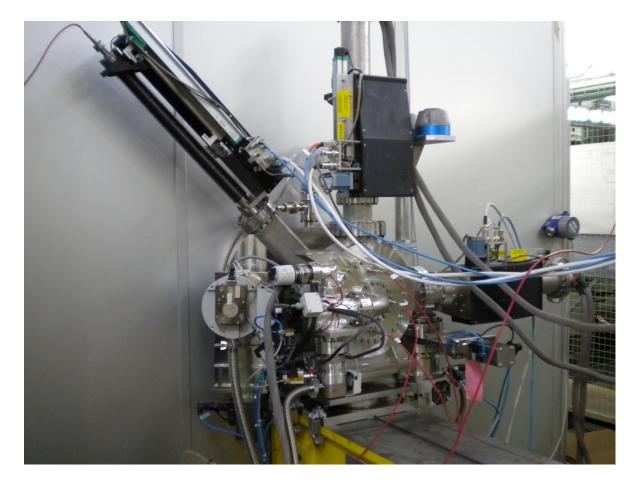






#### **Transverse Emittance Measurement**





Slit and grid phase space scanner

L-shaped 0.1mm slit moves under 45 degrees

Slit and grids move independently Positioning precision: 50 µm Movement PLC controlled

Slit and grids mounted in 2 independent vacuum boxes which can be separated

Horizontal and vertical SEMGrid

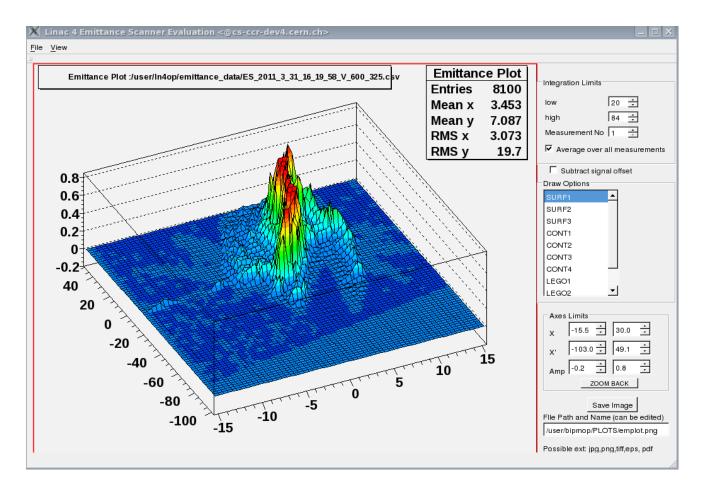
- wire distance .75 mm
- 30 signal wires
- readout with home built 36 channel 250 kHz ADC
- time resolved profiles

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#### **Emittance Evaluation**





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peak

#### Pseudo Scubexx evaluation

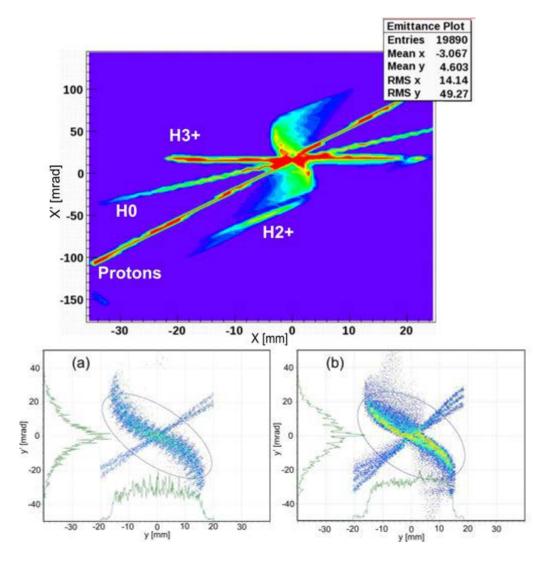


000 X Profile Histogram of signal levels SignalHisto BackgroundHisto chyrand Bringen Entries 50 Mean -1211 RMS 1234 ignalHistogram Entrins 16762 Integration Limits Mean Allenand RMS Allenand 8000 0.004 + 20 7000 high 0.0035 Background for each slit 5000 • 0.003 75 low 5000 Position 3.0025 \* Measurement No 0.002 11 100 3.0015 ÷ Threshold 1.00 **Emittance Plot** 2000 0.001 1000 3,000 Average over all measurements Emittance when taking less Subtract background Emittance Entries 22 Nean 7.411 and less channels around william and the second RHS 5344 Results + 45.00 H<sup>-</sup>energy 0.25 emittance mm -25.24 alpha 4.45 beta τ. 143.47 gamma Ok

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### **Emittance plot Solenoid**





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#### Parameters to be measured



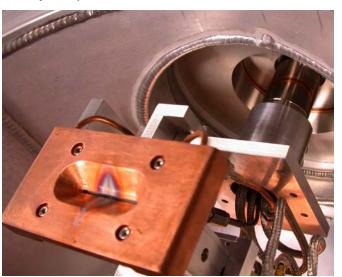
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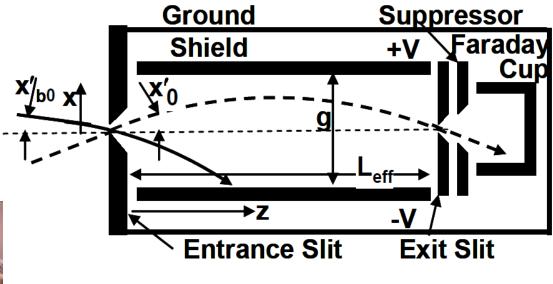


## Allison Scanner



The whole detector is passed through the beam Slit defines position Deflection plates with ramped electric field determine particle angles Angle distribution is measured with a Faraday Cup





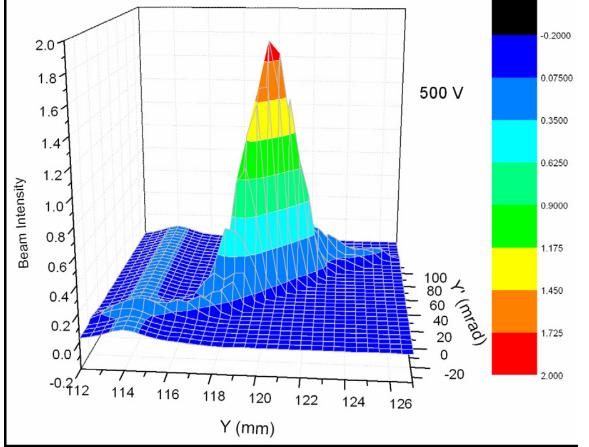
M. Stöckli, ORNL

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### Allison Scanner results SNS





Apply 10% threshold to get rid of background

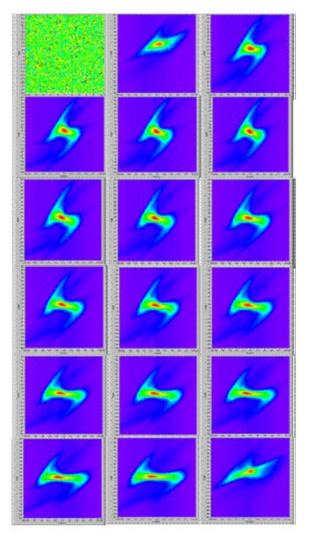




#### Emittance results along time axis



- First plot: no beam yet
- Big changes during the first 2 time slices (source plasma not stabilized yet)
- Then only small changes
- Last time slice: Big change due to decaying plasma when RF is switched off.



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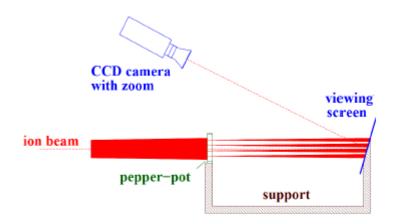


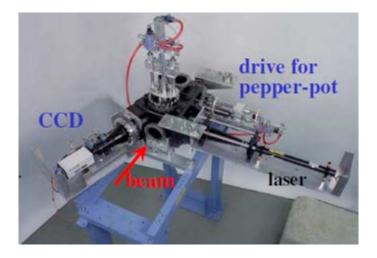
### **Pepperpot Emittance Measurement**



Advantage: Single shot measurement

Pepperpot: 15x15 holes on copper plate Luminescent screen Data acquisition: high resolution CCD Example from GSI Darmstadt





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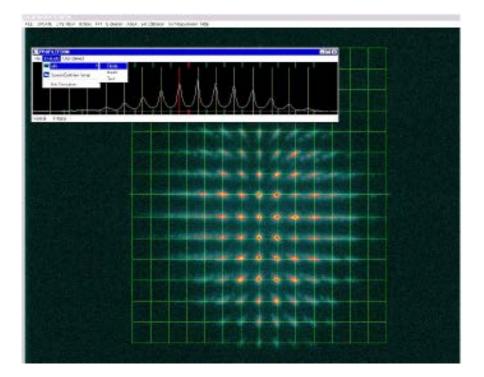
#### **Pepperpot Results**

30

25

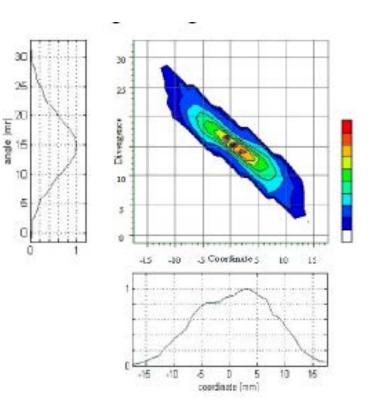
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Needs calibration of the screen to determine Orientation of the emittance ellipse

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#### Parameters to be measured



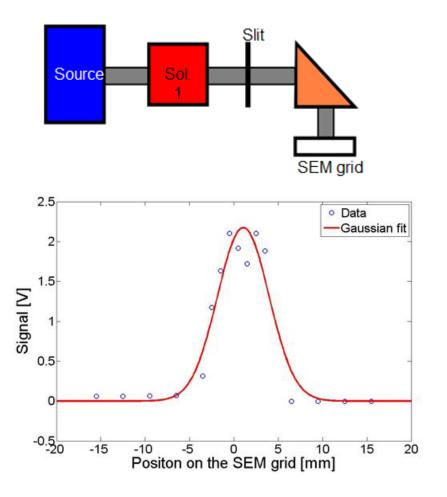
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# **Energy Spread**



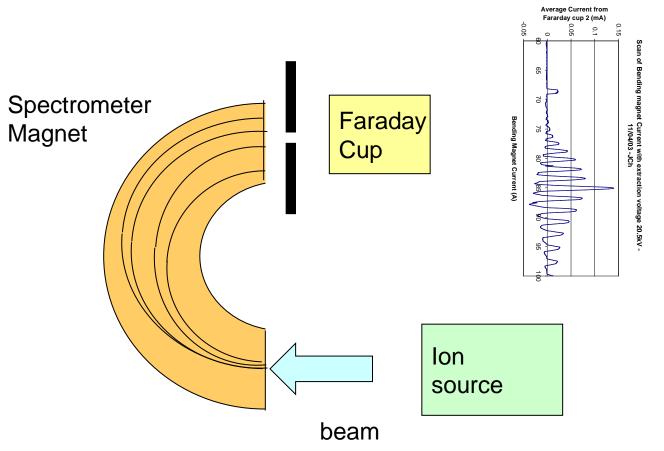
- Slit: reduces space charge effects and beam divergence
- Slit and wire grid are positioned at focal points of the optics
- Calibration by modification of the source extraction voltage (50 eV/mm)
- Profile width is determined by energy spread





#### Setup for charge state measurement





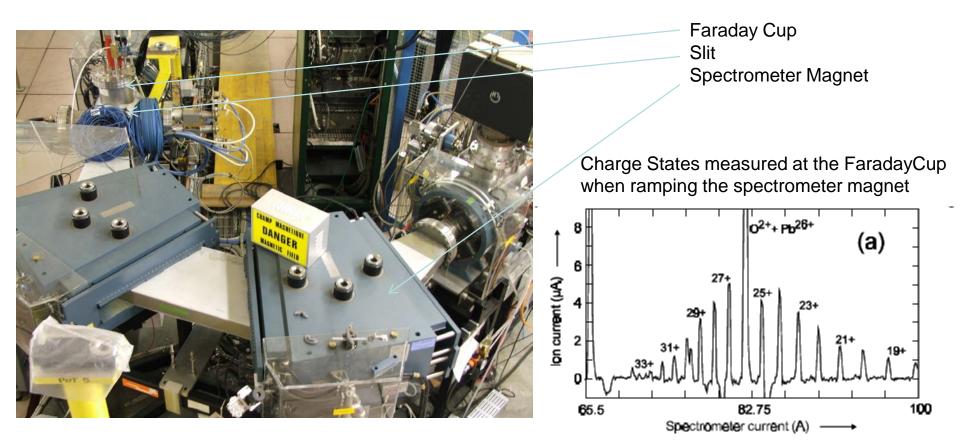
The spectrometer magnet is swept and the current passing the slit is measured

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### Select Charge States





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## Conclusions



- Beam diagnostics tells you how well your ion source performs
- Needed to understand LEBT optics to adapt source beam to RFQ characteristics
- Typical measurements:
  - Beam current and total intensity (no of charges)
  - Current stability over the beam pulse
  - Transverse Profile
  - Longitudinal Profile
  - Transverse emittance